imall

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BCV29, BCV49

NPN Silicon Darlington Transistors

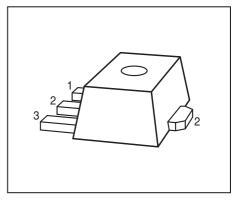
- For general AF applications
- High collector current
- High current gain
- Complementary types: BCV28, BCV48 (PNP)
- Pb-free (RoHS compliant) package
- Qualified according AEC Q101



AEC [®]					
Туре	Marking	Pin	Package		
BCV29	EF	1=B	2=C	3=E	SOT89
BCV49	EG	1=B	2=C	3=E	SOT89

Maximum Ratings

Parameter	Symbol	Value	Unit
Collector-emitter voltage	V _{CEO}		V
BCV29		30	
BCV49		60	
Collector-base voltage	V _{CBO}		
BCV29		40	
BCV49		80	
Emitter-base voltage	V _{EBO}	10	
Collector current	I _C	500	mA
Peak collector current, $t_p \le 10 \text{ ms}$	I _{CM}	800	
Base current	I _B	100	
Peak base current	/ _{BM}	200	
Total power dissipation-	P _{tot}	1	W
<i>T</i> _S ≤ 130 °C			
Junction temperature	Tj	150	°C
Storage temperature	T _{stg}	-65 150	





Thermal Resistance

Parameter	Symbol	Value	Unit
Junction - soldering point ¹⁾	R _{thJS}	≤ 20	K/W

¹For calculation of R_{thJA} please refer to Application Note AN077 (Thermal Resistance Calculation)

Electrical Characteristics at $T_A = 25^{\circ}$ C, unless otherwise specified

Parameter Parameter	Symbol		Values		Unit
		min.	typ.	max.	
DC Characteristics		[1	1
Collector-emitter breakdown voltage	V _{(BR)CEO}				V
<i>I</i> _C = 10 mA, <i>I</i> _B = 0 , BCV29		30	-	-	
<i>I</i> _C = 10 mA, <i>I</i> _B = 0 , BCV49		60	-	-	
Collector-base breakdown voltage	V _{(BR)CBO}				
I _C = 100 μA, I _E = 0 , BCV29		40	-	-	
I _C = 100 μA, I _E = 0 , BCV49		80	-	-	
Emitter-base breakdown voltage	V _{(BR)EBO}	10	-	-	
$I_{\rm E}$ = 10 µA, $I_{\rm C}$ = 0					
Collector-base cutoff current	I _{CBO}				μA
$V_{\rm CB}$ = 30 V, $I_{\rm E}$ = 0 , BCV29		-	-	0.1	
$V_{\rm CB}$ = 60 V, $I_{\rm E}$ = 0 , BCV49		-	-	0.1	
$V_{\rm CB}$ = 30 V, $I_{\rm E}$ = 0 , $T_{\rm A}$ = 150 °C, BCV29		-	-	10	
V_{CB} = 60 V, I_{E} = 0 , T_{A} = 150 °C, BCV49		-	-	10	
Emitter-base cutoff current	I _{EBO}	-	-	100	nA
$V_{\rm EB} = 4 \rm V, I_{\rm C} = 0$					
DC current gain ¹⁾	h _{FE}				-
I _C = 100 μA, V _{CE} = 1 V, BCV29		4000	-	-	
I _C = 100 μA, V _{CE} = 1 V, BCV49		2000	-	-	
<i>I</i> _C = 10 mA, <i>V</i> _{CE} = 5 V, BCV29		10000	-	-	
<i>I</i> _C = 10 mA, <i>V</i> _{CE} = 5 V, BCV49		4000	-	-	
<i>I</i> _C = 100 mA, <i>V</i> _{CE} = 5 V, BCV29		20000	-	-	
<i>I</i> _C = 100 mA, <i>V</i> _{CE} = 5 V, BCV49		10000	-	-	
<i>I</i> _C = 0.5 A, <i>V</i> _{CE} = 5 V, BCV29		4000	-	-	
$I_{\rm C}$ = 0.5 A, $V_{\rm CE}$ = 5 V, BCV49		2000	-	-	
Collector-emitter saturation voltage ¹⁾	V _{CEsat}	-	_	1	V
<i>I</i> _C = 100 mA, <i>I</i> _B = 0.1 mA					
Base emitter saturation voltage ¹⁾	V _{BEsat}	-	-	1.5	1
/ _C = 100 mA, / _B = 0.1 mA					



¹Pulse test: t < 300µs; D < 2%

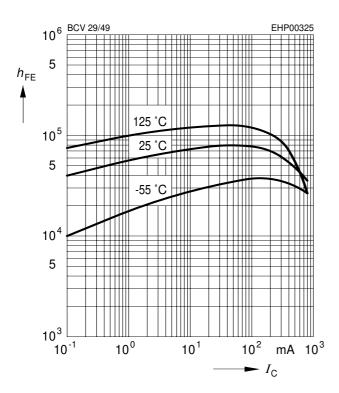
Electrical Characteristics at T_A = 25°C, unless otherwise specified

Parameter	Symbol	Values		Unit	
		min.	typ.	max.	
AC Characteristics	·				
Transition frequency	f _T	-	150	-	MHz
<i>I</i> _C = 50 mA, <i>V</i> _{CE} = 5 V, <i>f</i> = 100 MHz					
Collector-base capacitance	C _{cb}	-	3	-	pF
V _{CB} = 10 V, <i>f</i> = 1 MHz					



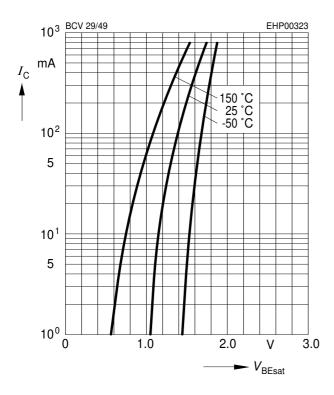
DC current gain $h_{\text{FE}} = f(I_{\text{C}})$

 V_{CE} = 5 V



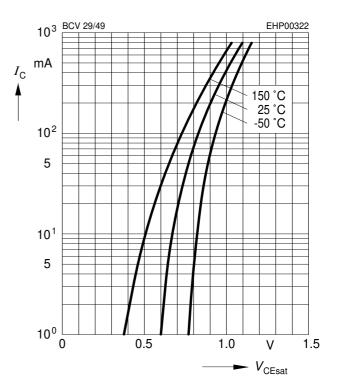
Base-emitter saturation voltage

 $I_{\rm C} = f(V_{\rm BEsat}), h_{\rm FE} = 1000$



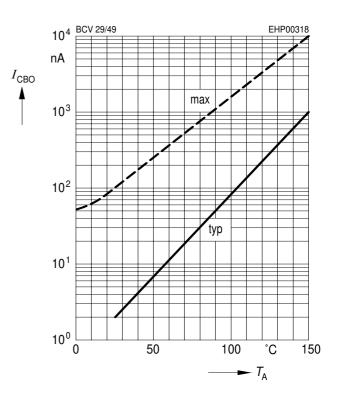
Collector-emitter saturation voltage

 $I_{\rm C} = f(V_{\rm CEsat}), h_{\rm FE} = 1000$



Collector cutoff current $I_{CBO} = f(T_A)$

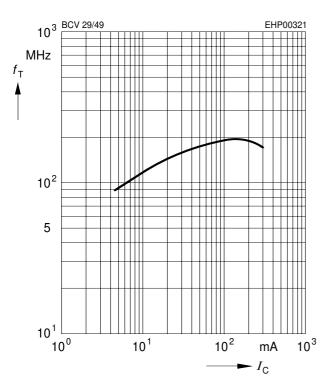
 $V_{\rm CB} = V_{\rm CEmax}$



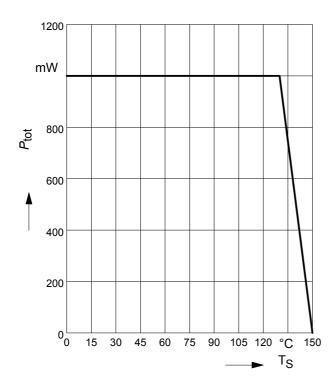


Transition frequency $f_{\rm T} = f(I_{\rm C})$

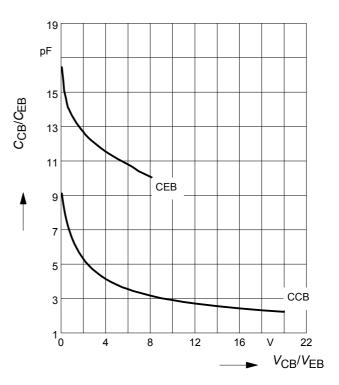
 V_{CE} = 5 V



Total power dissipation $P_{tot} = f(T_S)$

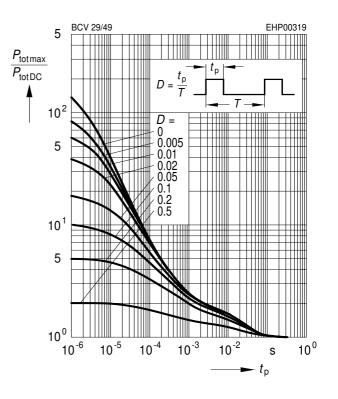


Collector-base capacitance $C_{cb} = f(V_{CB})$ Emitter-base capacitance $C_{eb} = f(V_{EB})$

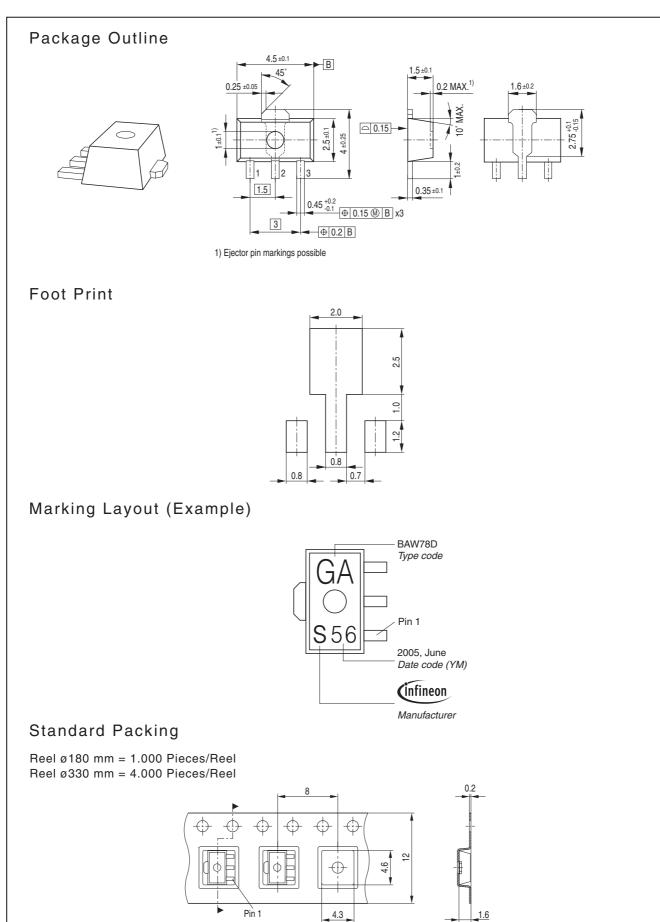


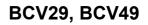
Permissible Pulse Load

 $P_{\text{totmax}}/P_{\text{totDC}} = f(t_p)$











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